

Notice of References Cited	Application/Control No. 10/092,685	Applicant(s)/Patent Under Reexamination LIN, SHIN CHAI MARK	
	Examiner Phylesha L. Dabney	Art Unit 2614	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,784,470	07-1998	Fackler et al.	381/328
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	L	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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